

### **STS5N15F4**

## N-channel 150 V, 0.057Ω, 5 A, SO-8 STripFET™ DeepGATE™ Power MOSFET

#### **Features**

Туре	V <sub>DSS</sub> R <sub>DS(on)</sub> max		I <sub>D</sub>
STS5N15F4	150 V	< 0.063 Ω	5 A

- N-channel enhancement mode
- 100% avalanched rated
- Low gate charge
- Very low on-resistance



■ Switching applications

#### **Description**

This STripFET™ DeepGATE™ Power MOSFET technology is among the latest improvements, which have been especially tailored to minimize on-state resistance, with a new gate structure, providing superior switching performances.

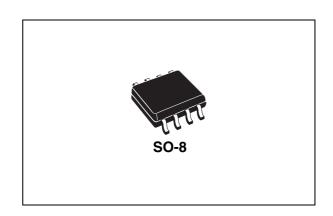


Figure 1. Internal schematic diagram

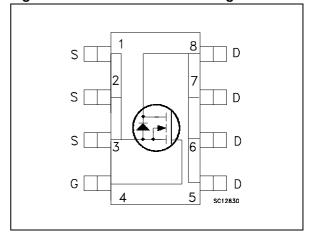


Table 1. Device summary

Order code	Order code Marking Package		Packaging
STS5N15F4	5U15-	SO-8	Tape and reel

Electrical ratings STS5N15F4

# 1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit		
$V_{DS}$	Drain-source voltage (V <sub>GS</sub> = 0)	150	V		
V <sub>GS</sub>	Gate-source voltage	± 20	٧		
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 25 °C	current (continuous) at T <sub>C</sub> = 25 °C 5			
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> =100 °C	3	Α		
I <sub>DM</sub> <sup>(1)</sup>	Drain current (pulsed) 20				
P <sub>TOT</sub>	Total dissipation at T <sub>C</sub> = 25 °C	2.5			
T <sub>stg</sub>	Storage temperature		°C		
Tj	Operating junction temperature	-55 to 150			

<sup>1.</sup> Pulse width limited by safe operating area

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R <sub>thj-pcb</sub> (1)	Thermal resistance junction-pcb max	50	°C/W

<sup>1.</sup> When mounted on FR-4 board of 1 inch², 2 oz Cu, t < 10 sec

Table 4. Avalanche characteristics

Symbol	Parameter	Max value	Unit
I <sub>AS</sub>	Avalanche current, repetitive or not-repetitive (pulse width limited by $T_j$ max)	5	Α
E <sub>AS</sub>	Single pulse avalanche energy (starting $T_j = 25$ °C, $I_D = I_{AS}$ , $V_{DD} = 140$ V)	125	mJ

# 2 Electrical characteristics

 $(T_J = 25 \, ^{\circ}C \text{ unless otherwise specified})$ 

Table 5. On/off states

Symbol	Parameter Test conditions		Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	I <sub>D</sub> = 1 mA, V <sub>GS</sub> = 0	150			٧
I <sub>DSS</sub>	Zero gate voltage drain current (V <sub>GS</sub> = 0)	V <sub>DS</sub> = 150 V, V <sub>DS</sub> = 150 V, @125 °C			1 10	μ <b>Α</b> μ <b>Α</b>
I <sub>GSS</sub>	Gate body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ±20 V			±100	nA
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2		4	V
R <sub>DS(on)</sub>	Static drain-source on resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 2.5 A		0.057	0.063	Ω

Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 25 \text{ V, f} = 1 \text{ MHz,}$ $V_{GS} = 0$	-	2710 180 69.5	-	pF pF pF
Q <sub>g</sub> Q <sub>gs</sub> Q <sub>gd</sub>	Total gate charge Gate-source charge Gate-drain charge	$V_{DD}$ = 75 V, $I_{D}$ = 5 A $V_{GS}$ =10 V Figure 14 on page 7	-	48 10.8 13.7	-	nC nC nC
$R_g$	Gate input resistance	f=1 MHz Gate DC Bias=0 Test signal level=20 mV open drain	-	1.9	-	Ω

Electrical characteristics STS5N15F4

Table 7. Switching times

Symbo	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$\begin{array}{c} t_{d(on)} \\ t_{r} \\ t_{d(off)} \\ t_{f} \end{array}$	Turn-on delay time Rise time Turn-off delay time Fall time	$V_{DD}$ = 75 V, $I_{D}$ = 3 A, $R_{G}$ =4.7 $\Omega$ , $V_{GS}$ =10 V Figure 13 on page 7	-	13.5 5.1 39.7 11.4	-	ns ns ns ns

Table 8. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max	Unit
I <sub>SD</sub>	Source-drain current		-		5	Α
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)		-		20	Α
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	$I_{SD} = 6 \text{ A}, V_{GS} = 0$	-		1.3	V
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD}$ = 6 A, di/dt = 100 A/µs, $V_{R}$ = 120 V, $T_{J}$ = 150 °C Figure 15 on page 7	-	85.2 277.6 8.2		ns nC A

<sup>1.</sup> Pulse width limited by safe operating area

<sup>2.</sup> Pulsed: pulse duration=300µs, duty cycle 1.5%

### 2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

Figure 3. Thermal impedance

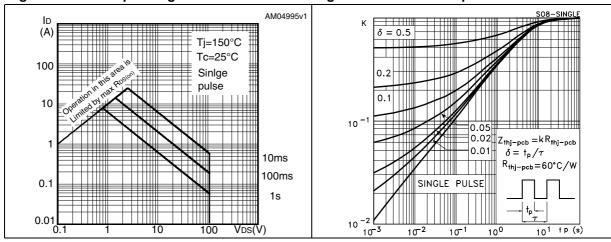


Figure 4. Output characteristics

Figure 5. Transfer characteristics

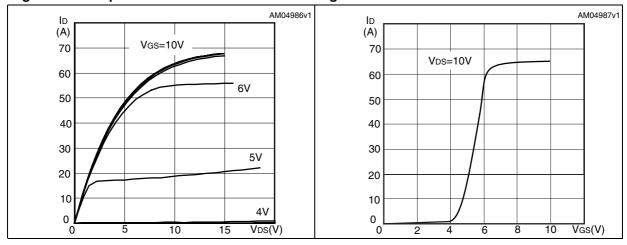
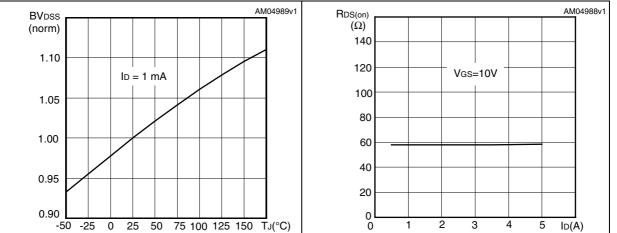


Figure 6. Normalized B<sub>VDSS</sub> vs temperature

Figure 7. Static drain-source on resistance



Electrical characteristics STS5N15F4

Figure 8. Gate charge vs gate-source voltage Figure 9. Capacitance variations

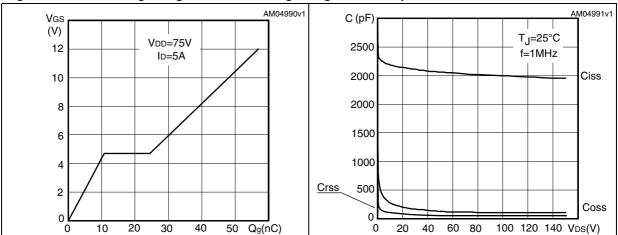


Figure 10. Normalized gate threshold voltage vs temperature

Figure 11. Normalized on resistance vs temperature

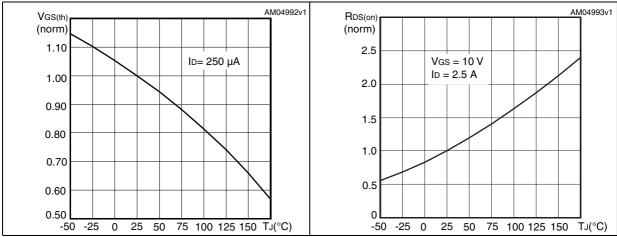
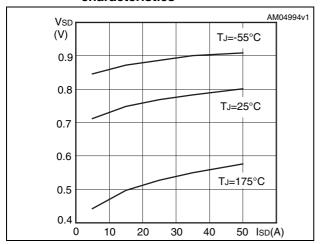


Figure 12. Source-drain diode forward characteristics



STS5N15F4 Test circuits

### 3 Test circuits

Figure 13. Switching times test circuit for resistive load

Figure 14. Gate charge test circuit

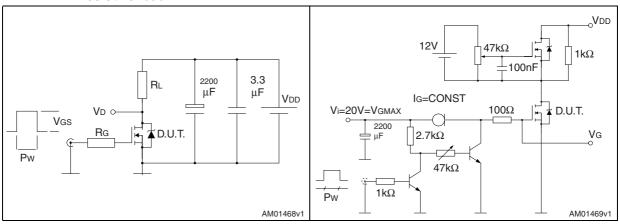


Figure 15. Test circuit for inductive load switching and diode recovery times

Figure 16. Unclamped inductive load test circuit

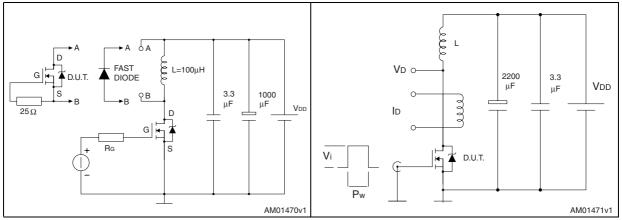
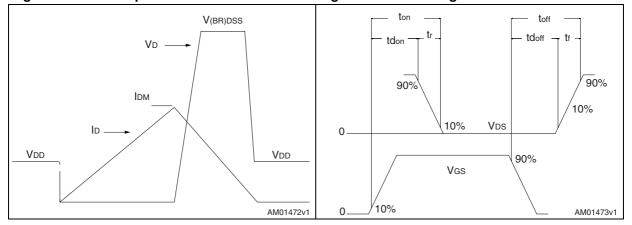


Figure 17. Unclamped inductive waveform

Figure 18. Switching time waveform



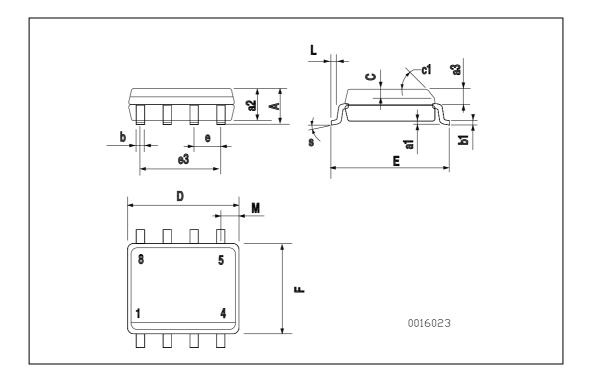
# 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

8/11 Doc ID 16083 Rev 2

#### **SO-8 MECHANICAL DATA**

DIM		mm.			inch	
DIM.	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
Α			1.75			0.068
a1	0.1		0.25	0.003		0.009
a2			1.65			0.064
a3	0.65		0.85	0.025		0.033
b	0.35		0.48	0.013		0.018
b1	0.19		0.25	0.007		0.010
С	0.25		0.5	0.010		0.019
c1			45	(typ.)		•
D	4.8		5.0	0.188		0.196
Е	5.8		6.2	0.228		0.244
е		1.27			0.050	
e3		3.81			0.150	
F	3.8		4.0	0.14		0.157
L	0.4		1.27	0.015		0.050
М			0.6			0.023
S		•	8 (r	nax.)	•	•



Revision history STS5N15F4

# 5 Revision history

Table 9. Document revision history

Date	Revision	Changes	
23-Jul-2009	1	First release	
03-Aug-2009	2	Updated figures 6, 7, 10 and 11	

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